Docket No.: 56937-087

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Customer Number: 20277

Chie KABUO : Confirmation Number:

Serial No.: : Group Art Unit:

Filed: September 05, 2003 : Examiner: Unknown

For: SYSTEM FOR ESTIMATING PERFORMANCE OF INTEGRATED CIRCUIT IN

REGISTER TRANSFER LEVEL

INFORMATION DISCLOSURE STATEMENT

Mail Stop IDS Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

Serial No.:

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

MCDERMOTT, WILL & EMERY

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Date: September 5, 2003

INFORMATION DISCLOSURE CITATION IN AN APPLICATION					ATTY. DOCKET NO. 56937-087	SE	SERIAL NO.		
					APPLICANT Chie KABUO				
(PTO-1449)					FILING DATE September 05, 200	FILING DATE GROUP September 05, 2003			
				U.S. PATE	NT DOCUMENTS				
EXAMINER'S INITIALS	CITE NO.			Publication Dat MM-DD-YYYY		Name of Patentee or Applicant of Cited Document		Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
		US	6,132,109	10/17/2000	Gregory et al				
	B1	US 6,519,754		02/11/2003	McElvain et a	McElvain et al.			
	A1	US 2003/0079195		04/24/2003	McElvain et a	McElvain et al.			
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FOREIGN PATENT DOCUMENTS									
EXAMINER'S INITIALS	CITE NO.			Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear			
	 			08/06/1999	HITACHI LTD	 	Yes (Japan w/English Abstract)	No	
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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.